

<b>Notice of References Cited</b>	Application/Control No. 10/518,299	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner Van T. Trieu	Art Unit 2612	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,897,827	05-2005	Senba et al.	343/873
*	C	US-6,160,526	12-2000	Hirai et al.	343/895
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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